

General Description

The WSF40N10 is the highest performance trench N-Ch MOSFET with extreme high cell density , which provide excellent RDS(on) and gate charge for most of the synchronous buck converter applications .

The WSF40N10 meet the RoHS and Green Product requirement , 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

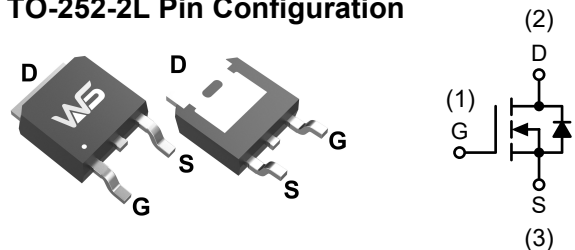
Product Summary

BVDSS	RDS(on)	ID
100V	32mΩ	26A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter
- Networking DC-DC Power System
- Load Switch

TO-252-2L Pin Configuration



Absolute Maximum Ratings(T_C=25°C)

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	100	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current	26	A
I _D @T _C =70°C	Continuous Drain Current	15	A
I _{DM} ^a	Pulsed Drain Current	72	A
EAS ^b	Single Pulse Avalanche Energy	36	mJ
P _D @T _C =25°C	Total Power Dissipation	54	W
P _D @T _C =100°C	Total Power Dissipation	21	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA} ^c	Thermal Resistance Junction-ambient	---	50	°C/W
R _{θJC}	Thermal Resistance Junction-Case	---	2.3	°C/W

Note a : Pulse width limited by max. junction temperature.

Note b : UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature T_J=25°C).

Note c : Surface Mounted on 1in² pad area.

Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	100	---	---	V
ΔBV _{DSS} /ΔT _J	BVDSS Temperature Coefficient	Reference to 25°C, I _D =1mA	---	0.098	---	V/°C
R _{DS(ON)} ^d	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =12A	---	32	45	mΩ
		V _{GS} =6.0V, I _D =10A	---	40	85	
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	2.0	3.0	4.0	V
ΔV _{GS(th)}	V _{GS(th)} Temperature Coefficient		---	-5.52	---	mV/°C
I _{DSS}	Drain-Source Leakage Current	V _{DS} =80V, V _{GS} =0V, T _J =25°C	---	---	10	uA
		V _{DS} =80V, V _{GS} =0V, T _J =55°C	---	---	100	
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V, V _{DS} =0V	---	---	±100	nA
g _{fs}	Forward Transconductance	V _{DS} =5V, I _D =15A	---	12	---	S
R _g	Gate Resistance	V _{DS} =0V, V _{GS} =0V, f=1MHz	---	2.5	---	Ω
Q _g ^e	Total Gate Charge (10V)	V _{DS} =50V, I _D =25A, V _{GS} =10V	---	28	---	nC
Q _{gs}	Gate-Source Charge		---	7.5	---	
Q _{gd}	Gate-Drain Charge		---	6.5	---	
T _{d(on)} ^e	Turn-On Delay Time	V _{DD} =50V, R _L =5Ω V _{GS} =10V, R _{GEN} =3Ω	---	8	---	ns
T _r	Rise Time		---	18	---	
T _{d(off)}	Turn-Off Delay Time		---	9	---	
T _f	Fall Time		---	29	---	
C _{iss} ^e	Input Capacitance	V _{DS} =50V, V _{GS} =0V, f=1MHz	---	1350	---	pF
C _{oss}	Output Capacitance		---	110	---	
C _{rss}	Reverse Transfer Capacitance		---	50	---	

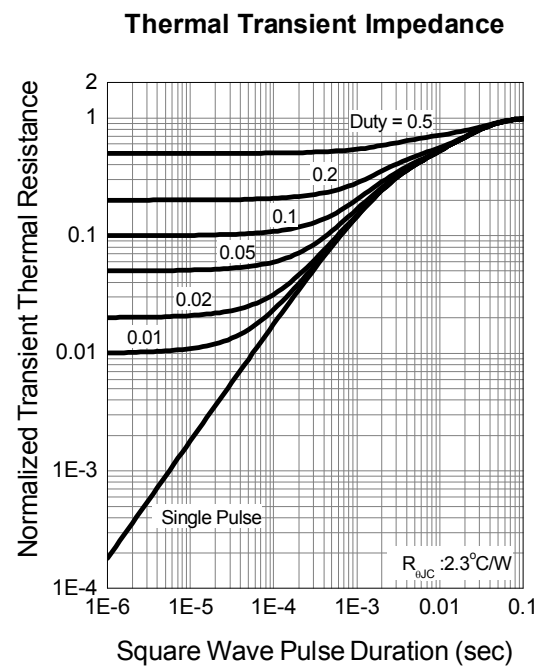
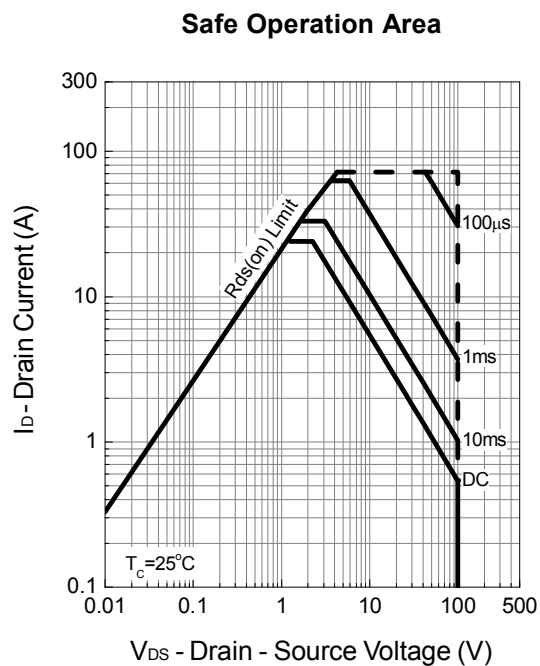
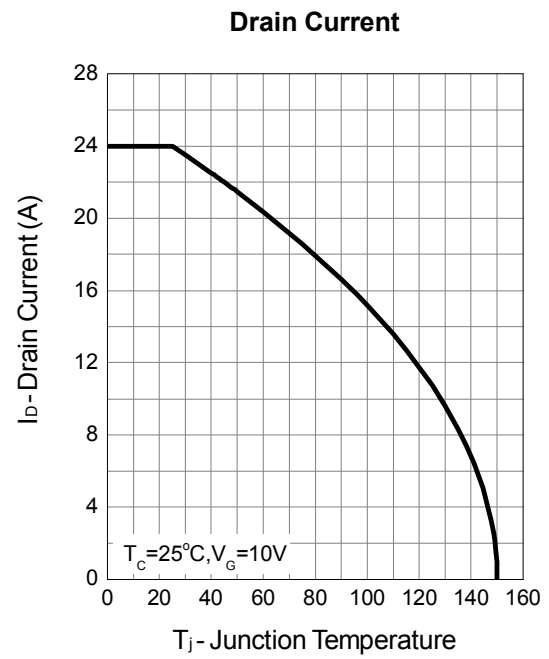
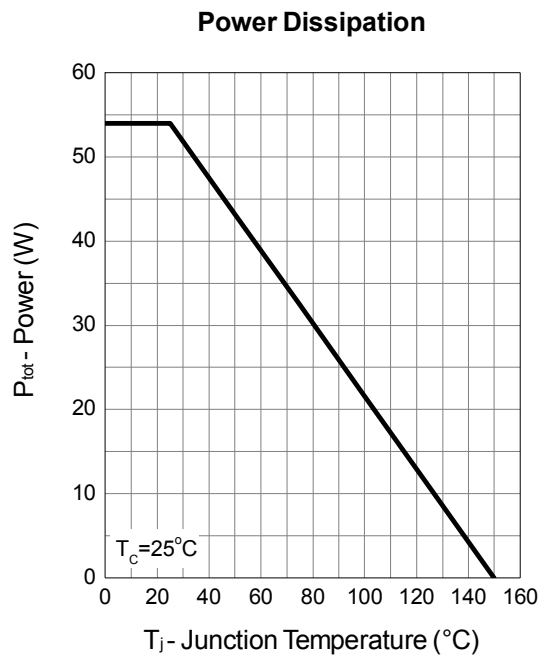
Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I _S ^a	Continuous Source Current	V _G =V _D =0V, Force Current	---	---	12	A
I _{SM}	Pulsed Source Current		---	---	38	A
V _{SD} ^d	Diode Forward Voltage	V _{GS} =0V, I _S =25A	---	---	1.3	V
t _{rr}	Reverse Recovery Time	T _J = 25°C, I _F = 25A di/dt = 100A/ μs	---	34	---	nS
Q _{rr}	Reverse Recovery Charge		---	56	---	nC

Note d : Pulse test ; pulse width≤300μs, duty cycle≤2%.

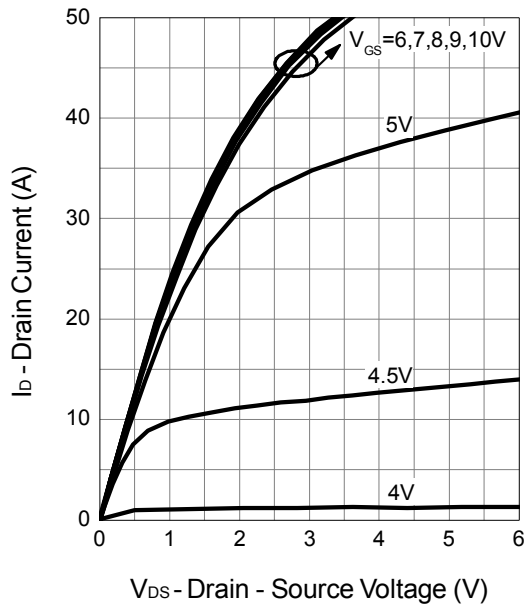
Note e : Guaranteed by design, not subject to production testing.

Typical Characteristics

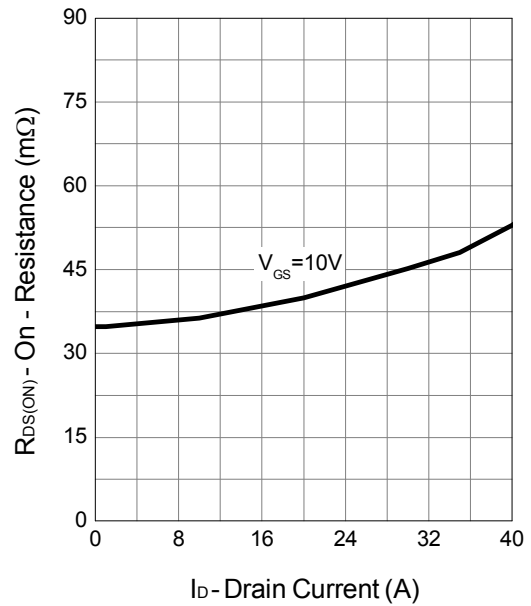


Typical Characteristics

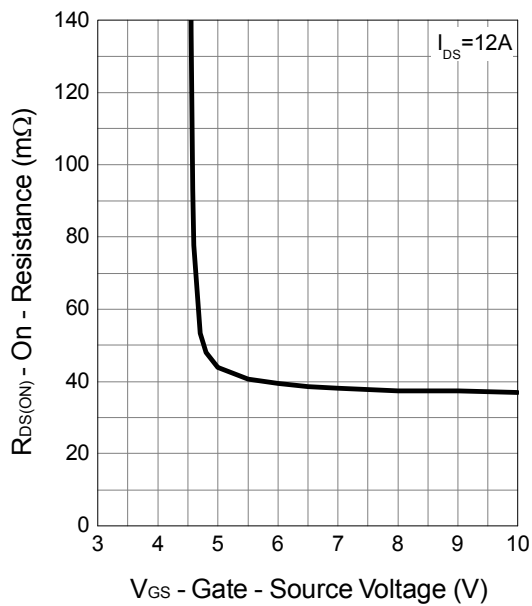
Output Characteristics



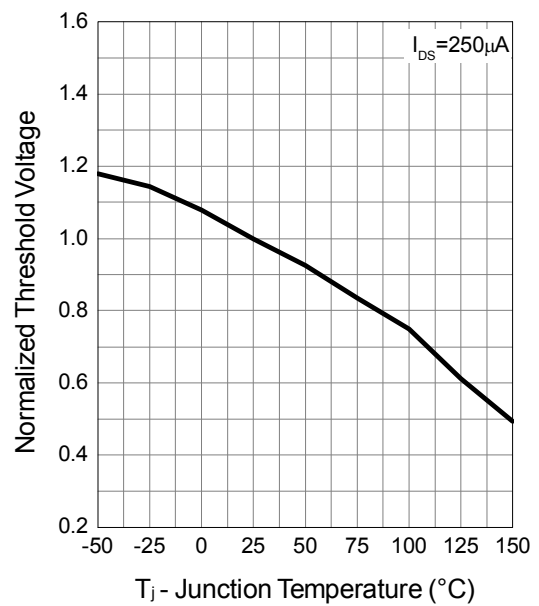
Drain-Source On Resistance



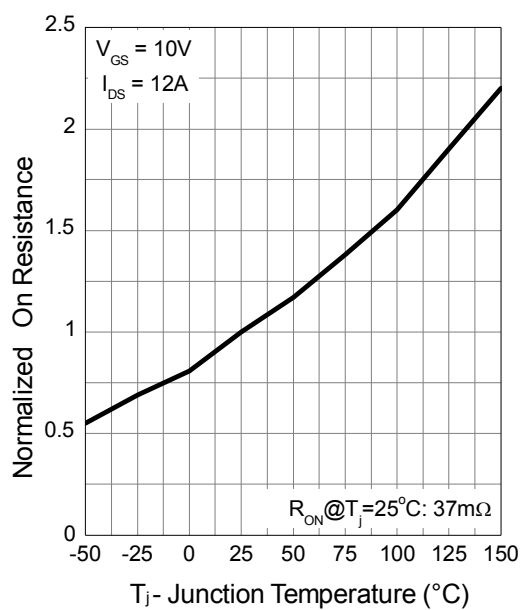
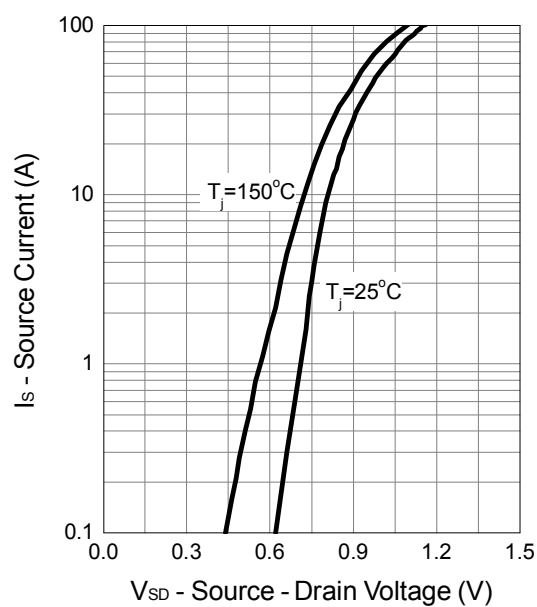
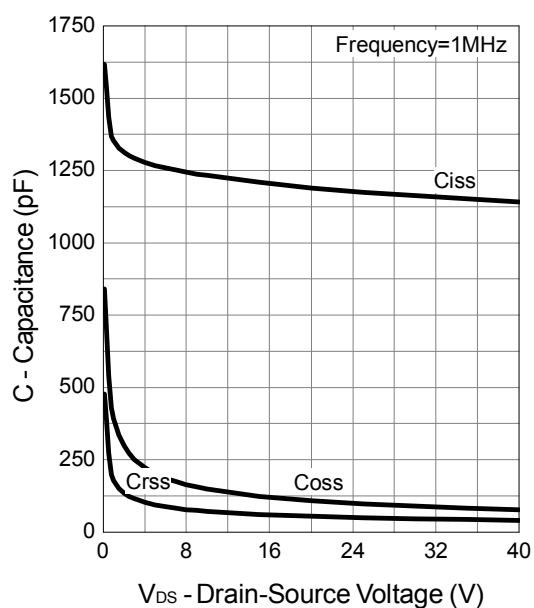
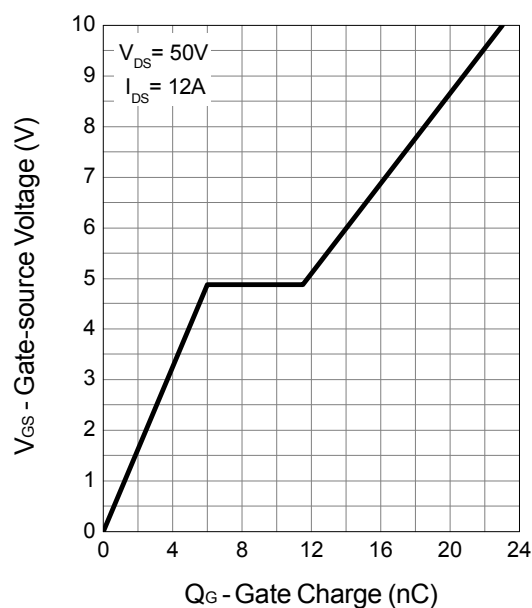
Gate-Source On Resistance

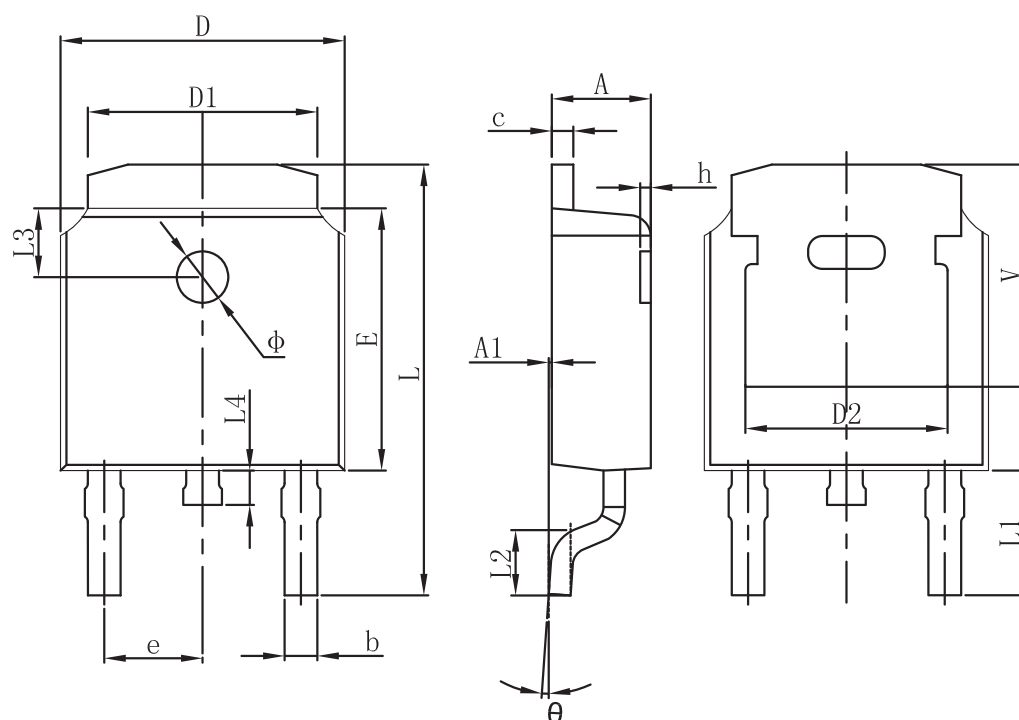


Gate Threshold Voltage



Typical Characteristics

Drain-Source On Resistance

Source-Drain Diode Forward

Capacitance

Gate Charge


Packaging information


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.635	0.770	0.025	0.030
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 REF.		0.190 REF.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.712	10.312	0.382	0.406
L1	2.900 REF.		0.114 REF.	
L2	1.400	1.700	0.055	0.067
L3	1.600 REF.		0.063 REF.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.250 REF.		0.207 REF.	

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